Modelling the spectral response of the Swift-XRT CCD camera: experience learnt from in-flight calibration

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ABSTRACT

Context. Since its launch in November 2004, Swift has revolutionised our understanding of gamma-ray bursts. The X-ray telescope (XRT), one of the three instruments on board Swift, has played a key role in providing essential positions, timing, and spectroscopy of more than 300 GRB afterglows to date. Although Swift was designed to observe GRB afterglows with power-law spectra, Swift is spending an increasing fraction of its time observing more traditional X-ray sources, which have more complex spectra.

Aims. The aim of this paper is a detailed description of the CCD response model used to compute the XRT RMFs (redistribution matrix files), the changes implemented to it based on measurements of celestial and on-board calibration sources, and current caveats in the RMFs for the spectral analysis of XRT data.

Methods. The RMFs are computed via Monte-Carlo simulations based on a physical model describing the interaction of photons within the silicon bulk of the CCD detector.

Results. We show that the XRT spectral response calibration was complicated by various energy offsets in photon counting (PC) and windowed timing (WT) modes related to the way the CCD is operated in orbit (variation in temperature during observations, contamination by optical light from the sunlit Earth and increase in charge transfer inefficiency). We describe how these effects can be corrected for in the ground processing software. We show that the low-energy response, the redistribution in spectra of absorbed sources, and the modelling of the line profile have been significantly improved since launch by introducing empirical corrections in our code when it was not possible to use a physical description. We note that the increase in CTI became noticeable in June 2006 (i.e. 14 months after launch), but the evidence of a more serious degradation in spectroscopic performance (line broadening and change in the low-energy response) due to large charge traps (i.e. faults in the Si crystal) became more significant after March 2007. We describe efforts to handle such changes in the spectral response. Finally, we show that the confirmed increase in the substrate voltage from 0 to 6 V on 2007 August 30 reduced the dark current, enabling the collection of useful science data at higher CCD temperature (up to $-50^{\circ} \mathrm{C}$). We also briefly describe the plan to recalibrate the XRT response files at this new voltage.

Conclusions. We show that the XRT spectral response is described well by the public response files for line and continuum spectra in the 0.3–10 keV band in both PC and WT modes.

Key words. gamma rays: bursts – X-rays: general – instrumentation: detectors – methods: numerical

1. Introduction

Successfully launched on 2004 November 20, the Swift gamma-ray burst satellite (Gehrels et al. 2004) consists of three instruments: the wide-field of view, gamma-ray burst alert telescope (BAT; Barthelmy et al. 2005) and two narrow field instruments (NFIs), the X-ray telescope (XRT; Burrows et al. 2005) and the UV/optical telescope (UVOT; Roming et al. 2005). Thanks to the unique ability of Swift to slew automatically after the BAT trigger, bursts are typically within the field of view of the narrow field instruments within a couple of minutes after the trigger. Thus, the XRT routinely provides positions with an accuracy of a few arc-seconds to the GRB community worldwide and measures the early X-ray light-curves and spectra of most GRB afterglows at which it is promptly pointed. Up to 2008 August 11, a total of 357 GRBs were detected by the BAT, of which 314 GRBs were observed by the XRT, although only 297 X-ray afterglows were thus detected by the XRT. Of these burst observations, 253 were prompt slews (i.e. less than 300 s after the BAT trigger), and the XRT detected 94\%\textsuperscript{1} of those bursts (i.e. 238 afterglows).

The Swift-XRT spectro-temporal observations associated with on-board and ground-based multi-wavelength observations have actively driven GRB science in the past three years by shedding new light on the physics of these objects. X-ray observations have revealed previously unexpected behaviour, including: multiple temporal breaks observed in some GRB light-curves

\textsuperscript{1} See http://swift.gsfc.nasa.gov/docs/swift/archive/grb_table/grb_stats.php
inconsistent with the standard afterglow models (e.g. Zhang et al. 2006; Nousek et al. 2006; O’Brien et al. 2006; Willingale et al. 2007) and the discovery of X-ray flares observed in about 50% of the Swift afterglows (e.g. Falcone et al. 2006, 2007; Chincarini et al. 2007; Goad et al. 2007; Godet et al. 2007a, 2006; Burrows et al. 2007). Recent work has shown that some spectra cannot be fit by simple absorbed power-laws due to curvature, which can be interpreted as spectral breaks caused by the temporal shift of the energy peak through the XRT energy band during X-ray flares (e.g. GRB 051117A: Goad et al. 2007; Chincarini et al. 2007; Godet et al. 2007a, 2007). In some other cases, the presence of an extra component was suggested (see Butler 2007; Moretti et al. 2008a, for a general study) such as a black-body component, which could be interpreted as: possible emission of a jet cocoon; the first-ever detection of a shock breakout from a massive star, likely a Wolf-Rayet, in the peculiar event GRB 060218 (Campana et al. 2006); possible photospheric emission for some X-ray flares in GRB 050822 (Godet et al. 2007a).

More detailed X-ray spectral analyses have shed light on the environment of GRBs and the nature of the progenitor itself. Campana et al. (2007) showed evidence that the progenitor of the high redshift GRB 050904 at $z = 6.3$ was located in a dense molecular cloud with a metallicity $Z > 0.03 Z_\odot$. Using detailed modelling of the low-energy part of the X-ray spectrum, Campana et al. (2008a) showed that the progenitor of GRB 060218 was likely to be a massive star characterized by a fast stellar rotation and initial sub-solar metallicity giving, for the first time, direct evidence about the properties of GRB progenitors.

Thanks to its large energy band-pass and the ability to rapidly schedule targets, Swift is also a powerful tool for obtaining essential insights into the physics of non-GRB objects, especially transients. For example, the XRT has provided essential spectroscopic information since the start of the outburst of the recurrent nova RS Ophichuchi in 2006, enabling, for the first time, detailed observations of the evolution of the Super-Soft Component in such an object (e.g. Bode et al. 2006; Hachisu et al. 2007). It also provided important spectroscopic information during the follow-up of several transient events (e.g., blazers: Tramacere et al. 2007; X-ray binaries: Esposito et al. 2007, Wijnands et al. 2007, Rykoff et al. 2007, Romano et al. 2007, Brocksopp et al. 2005; Comet 9P/Temple 1: Willingale et al. 2006; active galactic nuclei: Molina et al. 2007, Tueller et al. 2008). From the beginning of 2008, the fraction of time spent on non-GRB science targets has been ~45%, and this will increase in the future.

The results above show that X-ray spectroscopy is a powerful and essential tool for obtaining physical insights for celestial objects. These results depend on the intrinsic performance of the detector and the calibration of its spectral response. The XRT uses a front-illuminated e2v CCD-22, offering good spectroscopic performance with an energy resolution (FWHM) before launch of 135 eV at 5.9 keV (see also Fig. 1). The CCD-22 is a three phase frame transfer device, which utilises high resistivity (typically 4000 $\Omega$ cm) silicon and an open electrode structure, originally designed for, and used in, the EPIC (European Photon Imaging Camera) MOS cameras on-board XMM-Newton. The open electrode structure significantly improves the quantum efficiency of the device at low energy. The CCD imaging area consists of a 600 $\times$ 600 pixel array with a pixel size of 40 $\times$ 40 $\mu$m$^2$. Forty microns corresponds to 2.36 arcsec in the XRT field of view (e.g. Short et al. 2002). To mitigate the effects of pile-up, the CCD can automatically switch between different readout modes depending on the source brightness once the spacecraft is settled on the source (Hill et al. 2004, 2005):

1) photo-diode (PD) mode at the highest count rates with a 0.14 ms time resolution and no spatial information;
2) windowed Timing (WT) mode at moderate count rates, which uses a 200 column window covering the central 8 arcmin of the XRT field of view and provides 1D spatial imaging information. In that mode, the columns are clocked continuously to provide timing information in the trailed image along each column with a 1.8 ms time resolution, at the expense of imaging information in this dimension (pixels are binned by a factor of 10 along columns);
3) at lower count rates, Photon Counting mode (PC), which provides 2D spatial imaging information, but with a 2.5 s time resolution.

The PD mode has not been used since the CCD was hit by a particle (micro-meteoroid) on 2005 May 27 (Carpenter et al. 2006), due to the apparition of several bad columns on the detector, so we will focus only on the PC and WT modes in the remainder of the paper.

The XRT effective area (EA) is made up of the response of the mirrors, the filter placed in front of the CCD detector to reduce optical and UV photon loading and the CCD detector response. The mirror and filter responses are included in the auxiliary response files (ARFs), while the CCD response is included in the redistribution matrix files (RMFs).

To avoid any misinterpretation in the spectral analysis, it is essential to have a good understanding of the instrument response and its operational limitations. The aim of this paper is to describe in detail our CCD response model used to compute the RMFs, the changes that have been made to the RMFs and ARFs since the launch (based on in-flight calibration) and the caveats to be aware of in the spectral analysis of XRT data when using the current (version 11) response files distributed in the CALDB release on 2008-06-25. An overview of the other aspects of the XRT calibration can be found in Campana et al. (2008b) and a detailed study of the XRT background can be found in

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**Fig. 1.** Energy resolution ($\sigma = \frac{\omega \sqrt{\sigma^2 + \sigma^2}}{\omega}$) versus energy as measured during the ground calibration at the Leicester calibration facility using the in-flight CCD-22 cooled at -100 °C. The resolution was measured over the central 200 $\times$ 200 pixel window. The curve corresponds to the theoretical prediction given by $\sigma = \omega \sqrt{\sigma^2 + \sigma^2}$ where $F$, $E$, $\omega$ and $r$ are the Fano factor, the photon energy, the pair creation energy coefficient and the readout electronic noise, respectively. The thermal noise could be neglected with respect to the readout electronic noise due to the low temperature used during the measurements.
Moretti et al. (2008b). This paper is organised as follows: Sect. 2 – we describe the physics implemented in our RMF code. We also briefly describe the spectroscopic performance of the RMFs in both PC and WT modes prior to launch using ground calibration data; Sect. 3 – we discuss the in-flight operation of the XRT and its impact on the calibration of the XRT response, the calibration program, and in detail post-launch changes made to the CCD spectral model (low-energy response, line shoulder, shelf, RMF redistribution) and the ARFs based on celestial target calibration; Sect. 4 – we present the spectroscopic performance of the XRT for several celestial targets compared to observations; Sect. 5 – we present the spectroscopic performance of the ARFs.

### 2. Computation of the spectral response

The XRT spectral response is based on a physical model describing the interaction of photons within the silicon bulk of a CCD-22 pixel via Monte-Carlo simulations. A Monte-Carlo simulator was developed at the University of Leicester in order to generate the RMFs for all the XRT readout modes (Short et al. 2002; Mukerjee et al. 2004). The CCD response model was refined by implementing ad-hoc corrections in our code based on the ground and in-flight calibration. We discuss here the main steps used to generate the RMFs.

#### 2.1. RMF generation

Figure 2 shows the architecture of our CCD response model. To compute the RMFs, we stack simulated spectra of monochromatic X-rays using simple geometry of a CCD-22 pixel as input parameters, including the electrode structure, the finger and the open area (see Fig. 3) and the linear absorption coefficients of the different CCD compounds. The linear absorption coefficients used in our simulations include the effects of the rapid oscillatory X-ray Absorption Fine Structures (XAFS) just above the absorption edges of the CCD constituents (mainly N, O and Si) as measured by Owens et al. (1996a) for the JET-X CCD (see Fig. 4). It is essential to take them into account to obtain proper modelling of the spectral response around the edges.

##### 2.1.1. Carrier generation and charge spreading

0.2–10 keV photons impinging on the detector have a high probability of interacting via the photoelectric effect. This results in the generation of a charge cloud with an initial charge \( Q_0 \) given by:

\[
Q_0 = e \times \left( \frac{E_e}{\omega} + \sqrt{F \omega E_e x_R} \right)
\]

where \( F \) and \( \omega \) correspond to the Fano factor and the pair creation energy coefficient in the silicon, respectively. \( R \) is a random number uniformly distributed between 0 and 1; \( e \) is the elementary charge of the electrons (\( e = 1.6 \times 10^{-19} \) C). If the incoming photons have an energy \( E \) above \( E_{th} = 1.839 \) keV (i.e. the binding energy of the K-shell electrons in the silicon), then there is a 4.4% probability of producing a Si Kα fluorescence photon at 1.74 keV. In this case, the residual energy is \( E_{res} = E - 1.74 \) keV. Otherwise, we have: \( E_{res} = E \).

The newly formed charge cloud has an initial 1σ radius of

\[
r_1 = 0.0044 E_{res}^{1/25} \mu m
\]

assuming that the spatial distribution of the charge follows a Gaussian (Fitting et al. 1977). This charge cloud is collected in the buried channel in the depletion region after spreading in the bulk of the detector. The buried channel is defined as the potential well where the photo-generated charge will be collected and stored in a given CCD pixel between each readout. For the CCD-22, the buried channel covers the entire pixel size. The charge cloud may spread into more than one pixel, depending on its position with respect to the electrode structure and its depth, which is a function of the value of the linear absorption coefficients at the energy of the incoming photons (\( E \)) as follows:

\[
z = -\frac{1}{\mu_r(E)} \ln(P + \epsilon)
\]

where \( z \), \( \mu_r(E) \) and \( P \) are the depth of interaction of the incoming photons, the linear absorption coefficient and a number uniformly and randomly distributed between 0 and 1, respectively. A small offset \( \epsilon \ll 1 \) is introduced to avoid any singularity when \( P = 0 \).

The CCD pixel depth is divided into three regions:

- The depletion region: where the charges experience the full effect of the electric field (\( E \)). The radius of the charge cloud is modified as it drifts to the buried channel. The contribution to the charge cloud radius due to the spreading in the depletion region is given by:

\[
r_d = \sqrt{\frac{2kT \epsilon_e}{e^2 N_d}} \ln \left( \frac{z_d + \epsilon}{z_d - z + \epsilon} \right)
\]

where \( z_d \) is the thickness of the depletion depth, \( N_d \) – the silicon doping concentration (\( N_d = 8 \times 10^{12} \) cm\(^{-3}\)), \( \epsilon_e \) – the Si permittivity (\( \epsilon_e = 1.044 \times 10^{-12} \) F cm\(^{-1}\)), \( k \) – the Boltzmann constant and \( T \) – the temperature. We use a temperature of \( -60 \) °C in our code, which corresponds to the average CCD temperature in-orbit (see Sect. 3.2.3). CCD temperature fluctuations by ±10 °C do not change dramatically the \( r_d \)-values computed using Eq. (4) (i.e. by less than 2%). Equation (4) is undefined when \( z = z_d \). However, this singularity is not physical, so we introduced a small offset \( \epsilon = 0.002 \ll 1 \) to avoid this. All the charge reaching the depletion region is collected in the buried channel.

- The field-free region: where the charge no longer feels the effect of the electric field (i.e. a region where \( E \sim 0 \)). In this region, the charge experiences diffusion, recombination and trapping in the device lattice, so that the charge cloud can spread into several adjacent pixels. The contribution to the charge cloud radius, due to spreading in the field-free region, is given by (Janesick et al. 1985):

\[
r_{ff} = \frac{z_{ff}}{2} \left[ 1 - \left( \frac{z_d - z_{ff}}{z_{ff}} \right)^2 \right]^{1/2}
\]

where \( z_{ff} \) is the thickness of the field-free region and \( z_{ff} > 0 \) is the depth of the interaction in the field-free region. Assuming that the recombination losses can be neglected, the charge reaching the depletion layer boundary is given by (Hopkinson 1983):

\[
q_{ff} = Q_0 \frac{\cosh \left( \frac{z_d - z_{ff}}{z_{ff}} \right)}{\cosh \left( \frac{z_{ff}}{z_{ff}} \right)}
\]
Fig. 2. Architecture of the CCD response model used to compute the XRT RMFs. The RMFs contain 2400 input energy channels with a 5 eV energy width. In each energy channel, $N_{\text{max}} > 5 \times 10^5$ photons with an energy randomised in a given bin are considered in order to avoid adding numerical noise to the computation. $\mu(z)$ corresponds to the linear absorption coefficient in the silicon, which is a function of the energy of the incoming photons ($E$), while $\text{CTE}_s$, $\text{CTE}_p$ corresponds to the charge transfer efficiency during the readout process in the serial and parallel direction, respectively (see Sect. 3.2.2). $z$, $z_d$, $z_f$ correspond to the depth of interaction of the incoming photons ($z = 0$ corresponding to the surface of the Si active bulk), the depletion depth (an input parameter) and the field-free region depth defined as $z_f = \Delta z_{\text{CCD}} - z_d - z_s$ (where $z_s = 200 \ \mu$m is the thickness of the substrate and $\Delta z_{\text{CCD}} = 280 \ \mu$m is the thickness of the CCD). $F = 0.115$ and $\omega = 3.68$ eV per pair electron/hole are the Fano factor and the pair creation energy coefficient in the silicon, respectively, while $Q_0$ corresponds to the initial charge generated by the interaction of an incoming photon within the device. The different equations giving the total charge spreading radius ($r_t$) in the different layers of the CCD and the collected charge $Q(t)$ can be found in Sect. 2.1.1. $f(E, z)$ corresponds to a function describing the charge losses at the surface of the CCD (see Sect. 2.1.3). It depends on energy and depth of interaction of the incoming photons. Mostly photons interacting in the opened electrode area will suffer from surface charge losses (see the text in Sect. 2.1.3). The dashed lines correspond to the case where a 1.74 keV Kα fluorescence photon is emitted following the interaction of an incoming photon with an energy $E > E_b = 1.839 \ \text{keV}$ where $E_b$ is the electron binding energy for the Si K shell. The probability of generating such a fluorescence photon is 4.4%.

where $L_f$ is the value of the diffusion coefficient in the field-free region ($L_f \sim 4000 \ \mu$m). Equations (5) and (6) initially used to describe the diffusion in the field-free region have been modified to follow the formalism described in Sect. 3 in Pavlov & Nousek (1999), because the assumption that the radial distribution of the charge is Gaussian is no longer valid in this region (e.g. Pavlov & Nousek 1999; see also Sect. 3.3.3).

The substrate region: in which most of the charge produced is lost by diffusion and recombination, because the electron diffusion length is much shorter than in the two other regions. The contribution to the charge cloud radius due to spreading in the substrate region is given by (McCarthy et al. 1995)

$$r_s \sim \frac{L_s}{\sqrt{2}} \sqrt{1 - \left(\frac{z_s - z_3}{L_s}\right)^2}$$

(7)
Fig. 3. Pictures of the CCD-22 structure and geometry of a CCD-22 pixel as used in our spectral response code. (Top left and right panels) Top and side view of a CCD-22 pixel, respectively. These images were obtained by a scanning electron microscope provided by e2v. The different parts of the pixel are shown on these two images. (Bottom left and right panels) Geometry of the CCD-22 pixel as used in our CCD response model (the dimensions are given in units of μm): (left) top view of the simplified geometry of a CCD-22 pixel. The thicknesses of the compounds (Si, SiO₂, and Si₃N₄) present in the finger and electrode structures are shown in the equations giving the transparency of each part of the electrode structure on top of the silicon bulk (the coefficients Tᵢ); (right) Side view showing the different layers formed in the CCD (see text for more details). The epitaxial layer is 80 μm thick (p-type) and the substrate is 200 μm thick. The 0 in the z coordinate corresponds to the top of the Si active bulk, the electrode being on top of it. The incident X-ray photons enter from the top.

where zₛ is the thickness of the substrate, Lₛ – the diffusion length in the substrate which is much shorter than in the field-free region (Lₛ = 10 μm for Nₑ ~ 10¹⁸ cm⁻³) and z₃ = z – z₄ – zₓ is the depth of the interaction in the substrate. The diffusion length is replaced by zₛ when using Eq. (7) to avoid having (zₛ – z₃) > Lₛ (Short et al. 2002).

The total 1σ radius of the charge cloud reaching the buried channel is then given by the quadratic summation of the relevant radii assuming that the charge cloud profile due to radial diffusion is normally distributed:

\[ r = \sqrt{r₁² + r₂² + r₃² + rₛ²} \approx \sqrt{r₁² + r₂²} \]

(8)

The contribution of r₁ can be neglected with respect to that from the spreading radii r₂, r₃, and rₛ.

Figure 3 gives the thicknesses of these different layers as used in the CCD response model. The thickness of the depletion depth is an input parameter in our model. From quantum efficiency (QE) measurements performed at the Leicester calibration facility, we demonstrated that a 27 μm-thick depletion depth matches the on-ground calibration data using a substrate voltage of Vₓₑ = 0 V, as initially set in flight.
2.1.2. Event recognition process

The spreading of the charge cloud over several pixels implies that it is essential to use an event grade recognition process to retrieve the right energy of the incoming photons. We use the same event grade recognition process as implemented in the ground analysis software (XRTDAS software package\(^2\); Capalbi et al. 2005).

An event is formed when a pixel has an analogue-to-digital converted (ADC) charge greater than the event threshold (80 DN\(^3\)). This threshold is used to avoid pixels containing only noise from swamping the telemetry. In PC mode, the event data are telemetered as a 3 $\times$ 3 pixel matrix centred on the pixel with the most charge. Only the surrounding pixels for which the charge is above the split event threshold (40 DN) are considered in the grade mapping, the other pixels being discarded. The split event threshold was fixed at 40 DN to minimise the increase of the sub-threshold charge losses which result in a wing on the low-energy side of the line profile, and hence to minimise the degradation of the energy resolution (see Sects. 2.1.3 and 3.3.3).

Since the WT mode only offers 1D spatial imaging information (see Sect. 1), it is impossible to use a 3 $\times$ 3 pixel matrix in WT mode to classify the X-rays events. Instead, a seven pixel vector centred on the pixel with the most charge is used. In WT mode, the central and split event thresholds are both set at 80 DN. Figure 5 shows the list of the 32 and 15 event grades which can be formed in PC and WT modes, respectively. The PC grades are similar to those defined for the XMM-Newton MOS data (Burrows et al. 2005).

To eliminate events due to charged particles, and to obtain good energy resolution, we consider grades 0–12 in PC mode.

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\(^2\) http://swift.gsfc.nasa.gov/docs/swift/analysis/xrt_swguide_v1_2.pdf

\(^3\) Digital number.
and grades 0–2 in WT mode as valid X-ray events. From Fig. 5, the WT grade 0 includes the PC grades 0, 1 and 3 (i.e., the mono-pixel and vertical split events in PC modes), while the WT grades 0–2 includes the good PC grades 0–12 as well as possible higher PC grades 15, 17, 19, 21, 23, 25–29.

The pre-launch RMFs (v006) were released for three grade selections (0, 0–4 and 0–12) in PC mode and two grade selections (0 and 0–2) in WT mode. This was to offer the user the choice of higher spectral resolution at the cost of lower effective area. The decision was made after launch not to upgrade the PC grade 0–4 RMFs after the release of the v007 response files, since the PC grade 0–12 RMF offers a higher quantum efficiency at high energy and its calibration was sufficiently good.

2.1.3. X-ray spectrum from monochromatic radiation

The X-ray event energy spectrum resulting from monochromatic radiation with an energy $E$ significantly differs from a simple Gaussian. It consists of multiple components: a Gaussian photo-peak with a shoulder on the low energy side, a shelf extending to low energies, and, at the very lowest energies, the high-energy side of a noise peak above the on-board central event threshold (see Sect. 2.1.2). For photon energies above the Si K-shell edge (1.839 keV in the silicon bulk) two additional features appear: an escape peak of energy $E - E_{\text{Si}}$, and a Si Ka fluorescence peak at $E_{\text{Si}} = 1.74$ keV.

The DN value of the minimum energy threshold ($\text{thresh}$) in the spectra depends on the mode, the grade selection and the settings for the event threshold and the split event threshold in the ground processing code. The default threshold configuration for PC mode is 80 DN and 40 DN, respectively, and for WT mode both are set to 80 DN. Therefore, in PC mode, the default minimum energy threshold for grade 0 events is 80 DN while it is set at (80+40) DN for double split events, (80+(2×40)) DN for triple split events and (80 + (3 × 40)) DN for quadruple split events. In WT mode, the minimum energy threshold is set at 80 DN and 80 + 80 DN for grade 0 and grades 1 and 2 events, respectively. The $\text{thresh}$-values once expressed in units of eV (i.e. $\text{thresh} \times C_0 \times G$ where $C_0$ and $G (= 10)$ are the multiplicative DN to PHA (pulse height amplitude) gain factor and the global PHA to PI (pulse invariant) gain factor, respectively – see Eq. (10)) slightly increased over time, since the gain coefficient $C_0$ has increased by about 3% from launch to June 2007 (see Fig. 12 and Sect. 3.2.2).

At low energy, a large fraction of the photons interact at the interface between the SiO$_2$ layer placed on top of the silicon bulk and the active silicon bulk itself. Short et al. (2002) measured the lost fraction of the total charge formed at that interface. This energy loss results in a low-energy wing in the line profile as well as a shelf extending to low energy. The effects of the surface charge losses start to become very significant below 0.5 keV, since the photo-peak disappears almost completely and the electric field in the depletion depth; these act in addition to the surface losses. The exact shape of the shoulder and the shelf depend the readout mode (see Fig. 6 and the top panel in Fig. 7).

2.2. Performance of the pre-launch RMFs

The XRT CCD was calibrated using the EPIC calibration facility at the University of Leicester, using sixteen discrete energies covering the 0.3–10 keV energy range. These measurements were used to interpolate and generate the redistribution component of the XRT RMFs. The RMFs were initially calibrated for a value of the substrate voltage of $V_{\text{sc}} = 0$ V, which was the value used from launch to 2007 August 30 (see Sect. 4.3).

The pre-launch RMFs were computed to model the spectral response in the central region of the CCD, i.e. a window of 200 × 200 pixels (a field of view of about 7.9 × 7.9 arcmin$^2$). This area also corresponds to the area on the CCD where most of the GRB X-ray afterglows are located after the spacecraft slews.

Although the pre-launch RMFs showed good agreement between the calibration data and the model in many circumstances, as displayed in the top panel of Fig. 7, there were still some modelling issues. The low-energy shoulder of the high-energy ($E > 2–3$ keV) line profiles and the shelf needed improvement (see the bottom panel in Fig. 7).

3. In-flight calibration

3.1. Calibration overview

Regular in-flight spectroscopic calibration observations of a set of well-known celestial objects are performed (with a frequency of about 6 months) in order to monitor changes in the response
Table 1. Summary of the in-flight calibration targets used since the launch on 2004 November 20.

<table>
<thead>
<tr>
<th>Object</th>
<th>Type</th>
<th>Mode</th>
<th>Purpose</th>
<th>Exposure (ks)</th>
</tr>
</thead>
<tbody>
<tr>
<td>RXJ 1856.5-3754</td>
<td>Neutron star</td>
<td>PC/WT</td>
<td>Low energy response</td>
<td>81/70 (31/40)</td>
</tr>
<tr>
<td>PKS 0745-19</td>
<td>Cluster of galaxies</td>
<td>PC</td>
<td>Effective area</td>
<td>63 (20)</td>
</tr>
<tr>
<td>2E 0102-723</td>
<td>Line-rich SNR</td>
<td>PC/WT</td>
<td>Gain, energy resolution and shoulder</td>
<td>119 (28)</td>
</tr>
<tr>
<td>Cas A</td>
<td>Line-rich SNR</td>
<td>PC</td>
<td>Energy scale offset, gain, shoulder, CTI and energy resolution</td>
<td>76 (26)</td>
</tr>
<tr>
<td>3C 273</td>
<td>Quasar</td>
<td>WT</td>
<td>Effective area</td>
<td>18</td>
</tr>
<tr>
<td>PSR 0540-69</td>
<td>Pulsar</td>
<td>PC/WT</td>
<td>Effective area</td>
<td>56/26 (25 in PC)</td>
</tr>
<tr>
<td>PKS 2155-304</td>
<td>Blazar</td>
<td>PC/WT</td>
<td>Effective area</td>
<td>14/13 (5/9)</td>
</tr>
<tr>
<td>NGC 7172</td>
<td>Seyfert 2</td>
<td>PC</td>
<td>Redistribution</td>
<td>15</td>
</tr>
<tr>
<td>G21.5</td>
<td>Featureless SNR</td>
<td>PC</td>
<td>High-energy shelf</td>
<td>43 (78 in PC &amp; 77 in WT)</td>
</tr>
<tr>
<td>Mkn 421</td>
<td>Blazar</td>
<td>WT</td>
<td>Effective area</td>
<td>33 (10)</td>
</tr>
<tr>
<td>Crab</td>
<td>Pulsar/SNR</td>
<td>WT</td>
<td>Effective area</td>
<td>46 (5)</td>
</tr>
</tbody>
</table>

1 The letter indices x, c, s, r, i correspond to sources observed by other X-/Gamma-ray instruments for calibration purposes: XMM-Newton; Chandra; Suzaku; RXTE; INTEGRAL, respectively.

† The numbers in parentheses correspond to the exposure time collected from September 2007 to the end of December 2007 and dedicated to the re-calibration of the XRT after the substrate voltage change (see Sect. 4.3), while the other numbers correspond to the calibration data collected prior to the substrate voltage change on 2007 August 30.

‡ This symbol corresponds to the sources for which simultaneous calibration observations were performed with the XMM-Newton EPIC cameras.

Fig. 7. (Top panel) PC grade 0 spectrum measured at the Leicester calibration facility from the Si Kα and Si Kβ lines (1.74 and 1.84 keV) with background O Kα (0.525 keV) and bremsstrahlung continuum, together with pre-launch RMF v006. (Bottom panel) PC grade 0–12 spectrum measured at the Leicester calibration facility Mn Kα and Kβ lines (5.89 and 6.5 keV) from an on-board 55Fe source together with the pre-launch PC RMF v006. The low-energy shoulder and shelf are not fully reproduced by the model.

Fig. 8. CCD-22 simplified schematic diagram. The four 55Fe corner sources permanently illuminating areas of the CCD outside the field of view are shown as grey circles.

(see Table 1). The fraction of time spent on calibration since the launch is ~7% of the total in-orbit time. In addition, we make use of four 55Fe calibration sources which are located in each corner of the CCD and which permanently illuminate a small fraction of the CCD area outside the XRT field of view as shown in Fig. 8. Before the focal plane camera assembly (FPCA) door was opened, we also made use of an 55Fe calibration source located on the inside of the door, which illuminated the entire CCD imaging area.

Many of our calibration targets are also observed by other X-ray observatories such as XMM-Newton, Chandra, Suzaku and RXTE, enabling us to perform cross-calibration campaigns. So far, five cross-calibration campaigns with the XMM-Newton EPIC cameras on variable sources have been made (see Table 1 and Sect. 4.1). We also use the set of stable calibration sources.
observed by other X-ray instruments to compare and improve the performance of our spectral response (see Table 1 and Sect. 4.1).

3.2. Energy scale offsets and origins

Before describing the post-launch improvements made in our CCD response model, we address an important issue related to energy scale offsets, since they can lead to misinterpretation of the data and hence strongly affect the modelling of the response, especially around the instrumental edges. Below, we discuss four different causes resulting in energy scale offsets and describe the solutions which were found to correct the XRT energy scale.

3.2.1. Evaluation of the bias level

In addition to thermal noise, each pixel charge will carry with it a fixed zero-point offset DN value, a random readout noise from the amplifier and the noise from camera electronics. The zero-point offset defines the bias level measured on the CCD. The amplifier readout noise and the electronic noise, however, affect the determination of the bias level, but we minimize those contributions by averaging multiple bias measurements. In any case, the noise contributions should be much less than the measured offsets. In orbit, bias frames in PC mode and bias rows in WT mode are taken during each slew of the spacecraft to a new target before the beginning of an observation. For PC mode, the bias is computed on a pixel-by-pixel basis. Five 600 × 600 pixel frames are taken, averaging each into the existing bias map using a “running-mean” algorithm that sets each pixel \((x, y)\) to a new mean value computed as follows:

\[
\text{MeanPix}_{i+1}(x, y) = \frac{(N-1)}{N} \text{MeanPix}(x, y) + \frac{\text{Pix}(x, y)}{N}
\]

where \(N = 3\) is the running mean length and \(i = 1, \ldots, 5\) is the frame count. For WT mode, the bias row is a vector of bias values, one for each column in the WT mode window (i.e. 200 columns). The bias row vector is computed over one image of 600 rows. A “running-mean” approximation is computed for each pixel \(x\) in each row according to the following equation:

\[
\text{MeanPix}_{i+1}(x) = \frac{(N-1)}{N} \text{MeanPix}(x) + \frac{\text{Pix}(x)}{N}
\]

with \(N = 3\) and \(i\) corresponding to the row. The bias information is then used to correct on-board the subsequent frames of data during the XRT observations.

The bias level is mode dependent, and we have also seen observational evidence that the bias level can significantly vary even during a single snapshot on a celestial target (i.e. over ~20 min). Variations of the measured bias level can be due to changes in the CCD temperature following some sky pointing directions. Shifts in the CCD bias level are also caused by roughly sinusoidal temperature variations of ±3 °C during each 95 min orbit. The measured bias level can also be contaminated by scattered optical light from the sunlit Earth as shown in the top panel in Fig. 9 (see Beardmore et al. 2007, for more details). Scattered optical light from the sunlit Earth mainly affects PC mode because of its much longer frame accumulation time than WT mode, and seems to occur when the instrument is pointed near the sunlit Earth horizon. Changes in the bias level in both WT and PC modes result in energy scale offsets (see Fig. 10).

In order to correct the bias level on the ground, and hence restore the energy scale (see Fig. 10), the task xrtwtcorr, for WT mode, was enabled in the xrtdas software package (Swift software v.2.6). For PC mode, a new task xrtptbias was developed and released with Swift software v.2.7.

In addition to producing energy scale offsets, in some extreme cases scattered optical light in PC mode can induce a significant grade migration from good grades (grades 0−12) to higher rejected grades, resulting in an apparent loss of counts in the light-curve (see the bottom panel in Fig. 9). In these extreme cases, the xrtptbias task will not be able completely to correct the bias level and a residual energy scale offset will be still present in the spectra.

3.2.2. Increase of charge transfer inefficiency

CCD detectors provide good X-ray imaging and spectroscopic performance. However, the increase of charge transfer inefficiency (CTI) over time due to radiation damage is a fundamental limitation of CCD technology. Due to the effects of CTI, charge is lost during the readout process so that the remaining charge \(Q\)
reaching the output amplifier after \( N_1 \) transfers in the serial direction and \( N_p \) transfers in the parallel direction is

\[
Q = Q_0 (1 - CTI_s)^{N_s} (1 - CTI_p)^{N_p}
\]

where \( Q_0 \) is the initial charge and \( CTI_{s,p} \) are the serial and parallel CTI values, respectively. The CTI increase in the imaging area, the store-frame area and the serial register can then result in an energy scale offset if the data are not corrected. As an example, Fig. 11 shows the WT grade 0–2 spectrum of Cas A in the Si \( K\alpha \) and S \( K\alpha \) lines at different epochs when the data are not corrected for the effects of CTI. An offset of \(-50 \) eV is clearly visible between February 2005 and June 2007.

The XRT gain file takes into account the effect of CTI as follows:

\[
PI = \frac{PH A \times (C_0 + C_1 \times x + C_2 \times y) + C_3}{G}
\]

where \( x \) and \( y \) correspond to the position of the event in the CCD imaging area. \( G = 10 \) is the global PHA to PI gain factor. \( C_0 \) is the multiplicative DN to PHA gain factor, while \( C_{1,2} = C_0 \times CTI_{s,p} \) are the multiplicative serial and parallel CTI correction factors, respectively (see Pagani et al. 2008, for more details). \( C_1 \) is an additive offset correction factor which was set to 0 in both PC and WT modes before launch. \( C_{0,1,2} \) are functions of the CCD temperature (see Sect. 3.2.3) and time. The \( CTI_{s,p} \) values used to compute the \( C_{1,2} \) coefficients in the gain file are the same for all CCD temperatures (see Sect. 3.2.3).

Since launch, the evolution of serial and parallel CTI and the gain over time have been monitored using the four corner calibration sources (see Fig. 8). The gain \( C_0 \) is given by the gain of the bottom left corner source CS1 closest to the output amplifier, as this does not suffer from CTI loss in the imaging area. \( C_0 \) includes both the output amplifier gain and the degradation in the gain caused by charge loss during the frame-store transfer. CTI, is measured using corner source pair CS1 and CS3, while CTI, measured using corner source pair CS1 and CS2. Figure 12 shows the evolution of the gain \( C_0 \) (from 2.529 just after launch to 2.625 in June 2007) and the \( CTI_{s,p} \) values over time. Figure 12 shows a jump in gain \( C_0 \) around MET (Mission Elapsed Time) \( 2.1 \times 10^5 \) s due to the substrate voltage change from \( V_s = 0 \) V to 6 V (see Sect. 4.3). There also is a jump in CTI around MET \( 1.6 \times 10^5 \) s; the origin of this jump is however unknown. The
Table 2. Summary of the releases of the XRT post-launch gain files.

<table>
<thead>
<tr>
<th>Release number</th>
<th>Release date</th>
<th>Main improvements in the gain file</th>
<th>Text section number</th>
</tr>
</thead>
<tbody>
<tr>
<td>05</td>
<td>2005 April 3</td>
<td>Introduction of a temperature-dependent gain file</td>
<td>3.2.3</td>
</tr>
<tr>
<td>06</td>
<td>2005 October 28</td>
<td>Update of the gain coefficients over time</td>
<td></td>
</tr>
<tr>
<td>07</td>
<td>2007 July 9</td>
<td>Update of the gain coefficients in WT &amp; PC modes after the substrate change from 0 V to 6 V on 2007 August 30</td>
<td>3.2.2</td>
</tr>
<tr>
<td>08</td>
<td>2008 June 25</td>
<td>Introduction of an offset of ( C_1 = 1.6 \text{ eV} ) to restore the WT energy scale</td>
<td>3.2.4</td>
</tr>
</tbody>
</table>

The v003-v004 gain files correspond to the pre-launch gain files.

The v007-r008 gain files correspond to the pre-launch gain files.

The gain files have now added a suffix “s0” or “s6” to indicate the appropriate substrate voltage \( V_{ss} \). The “s0” files are valid from the start of the mission until when the substrate voltage was raised to \( V_{ss} = 6 \text{ V} \) on 2007 August 30.

![Graph showing the evolution of the gain \( C_0 \) at a CCD temperature of \(-65 \text{ °C}\). The gain coefficients are computed at two CCD temperatures of \(-100 \text{ °C}\) and \(-65 \text{ °C}\) using the ground calibration.

3.2.3. The effect of temperature

The XRT was designed to cool the CCD to a nominal operating temperature of \(-100 \text{ °C}\) using a thermo-electronic cooler (TEC). However, the TEC power supply system apparently failed shortly after launch, and the XRT has to rely on passive cooling via a heat pipe and radiator, in combination with enhanced management of the spacecraft orientation to reduce the radiator view of the sunlit Earth. The XRT is now operated with CCD temperatures varying between \(-75\) to \(-52 \text{ °C}\) (see Kennea et al. 2007, for more details), though new GRBs occasionally cause it to exceed \(-52 \text{ °C}\).

Since the gain of the CCD output FET (Field Effect Transistor) is sensitive to the reduced temperature, the temperature stability required the introduction of a temperature dependency in the gain expression in order to restore the XRT energy scale. In addition to the \( K\alpha \) and \( K\beta \) fluorescent lines of the corner source data, we used the supernova remnant Cas A, because its spectrum shows intense silicon \((1.86 \text{ keV})\) and sulphur \((2.45 \text{ keV})\) lines as well as an iron \((6.6 \text{ keV})\) line. The gain coefficient \( C_0 \) in Eq. (10) was computed at two CCD temperatures other than the \(-100 \text{ °C}\) used during the ground calibration: \(-65 \text{ °C}\) and \(-48 \text{ °C}\) using in orbit Cas A data. The ground data processing software linearly interpolates between tables of gain coefficients for these three different temperatures to determine the correct value to use for a given observation. These temperature-dependent values of \( C_0 \) were used to compute the coefficients \( C_{1,2} \) as well (see Sect. 3.2.2). The linear slope characterizing the gain change as a function of temperature from \(-65 \text{ °C}\) to \(-48 \text{ °C}\) is 0.00117 eV DN\(^{-1}\) C\(^{-1}\). This corresponds to a \( \sim 7 \text{ eV} \) variation in the energy scale at 1.5 keV for a \( 10 \text{ °C} \) temperature variation. This temperature dependency on the gain was included in the v007 release of the PC and WT gain files.

3.2.4. Comparison of the WT and PC energy scale

We found that even after correcting the data for the various sources of energy scale offsets discussed in previous sections, there was still a slight systematic mismatch between the WT and PC energy scales (see the top panel in Fig. 13). We estimated the systematic offset to be 17.6 eV, based on the comparison of the line centroids between WT and PC Cas A spectra, as well as the use of the XMM-RGS model to fit the XRT/WT spectra of the SNR E0102-723 using the gain command within Xspec (Arnaud 1996). This energy shift appears to be independent of time, temperature and energy. The setting of the offset term \( C_3 \) in Eq. (10) at 17.6 eV in the WT gain file was shown significantly to improve the WT energy scale (see the bottom panel in Fig. 13). This new v008 WT gain file was released on 2008 June 25 (see Table 2). The origin of the energy offset in WT mode is unclear and still under investigation.

3.3. Improvements to the response model

We discuss in this section the improvements made to the CCD response model based on experiences from in-flight calibration. Table 3 summarises the improvements made to the response files and the corresponding release number.

3.3.1. The low-energy response

Shortly after launch, it became apparent that the low energy \((E < 0.5 \text{ keV})\) response model could be improved. Figure 14 shows that the PC grade 0 spectrum of the soft neutron star RX J1856.4-3754 (the black curve) is poorly fitted when the v007 RMF is

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Footnote: http://swift.gsfc.nasa.gov/docs/heaarc/caldb/swift/docs/xrt/SWIFT-XRT-CALDB-04_v2.pdf
Table 3. Summary of the releases of the XRT post-launch RMFs.

<table>
<thead>
<tr>
<th>Release number</th>
<th>Release date</th>
<th>Main improvements in the RMFs</th>
<th>Text section number</th>
</tr>
</thead>
<tbody>
<tr>
<td>07</td>
<td>2005 April 5</td>
<td><strong>Line shoulder</strong>: ad-hoc increase of threshold to favour sub-threshold losses in PC &amp; WT mode</td>
<td>3.3.3</td>
</tr>
<tr>
<td>08</td>
<td>2006 April 24</td>
<td><strong>Low-energy response</strong>: change in the description of the surface loss function in PC &amp; WT mode</td>
<td>3.3.1</td>
</tr>
<tr>
<td>09†</td>
<td>2007 May 31</td>
<td><strong>Line shoulder</strong>: New description of the charge cloud in the field-free region for high-energy photons ( (E &gt; 2, \text{keV}) ) in PC mode</td>
<td>3.3.3</td>
</tr>
<tr>
<td></td>
<td></td>
<td><strong>Shelf</strong>: Rescaling of the shelf in both PC &amp; WT mode</td>
<td>3.3.2</td>
</tr>
<tr>
<td>11‡</td>
<td>2008 June 25</td>
<td><strong>Loss function</strong>: New description of the surface loss function in the 1-2 keV energy range in WT mode</td>
<td>3.3.4</td>
</tr>
</tbody>
</table>

† The v006 response files correspond to the pre-launch response files.
‡ The v009 response files were renamed as v010 response files when the substrate voltage was raised from 0 to 6 V on 2007 August 30 (see Sect. 4.3) following an update of the ground software.

\[ f(E_{i,1}, z) = \begin{cases} 0, & z \leq 0 \text{ or } z \geq \Delta z_{\text{CCD}} \\ f_0 + A \left( \frac{E}{E_{\text{th}}} \right)^\gamma, & 0 \leq z < l \\ 1 - B e^{-\frac{z}{\tau}}, & l \leq z < \Delta z_{\text{CCD}} \end{cases} \]

where \( f_0, c, l \) and \( \tau \) are free parameters which were estimated initially by fitting the previous loss functions in each energy band \( \Delta z_{i,1.2} \) as defined in Sect. 2.1.3, and then by using an iterative process of RMF generation and fits of spectra of soft neutron stars and ground calibration data. \( \Delta z_{\text{CCD}} \) is the CCD thickness (\( \Delta z_{\text{CCD}} = 280 \, \mu\text{m} \)). The parameters \( A \) and \( B \) were derived using \( f(E_{i,1,2}, z = l) \) and \( f'(E_{i,1,2}, z = l) = \frac{df}{dl} \). This new description gives better results as shown in Fig. 14 (the red curve). This description was included in the v008 release of the PC and WT RMFs.

Fig. 13. Spectra of the entire SNR Cas A in WT mode at different epochs: (black) 2005-02-16; (red) 2006-04-20; (green) 2007-06-06. The blue line indicates the expected energy centroid of the Si and S Kα lines. (Top panel) Data processed using the v007 WT gain file. (Bottom panel) Data processed using the v008 WT gain file including an offset of 17.6 eV.

Fig. 14. Comparison of the low-energy response between v007 (black) and v008 (red) RMFs using the spectrum of the soft neutron star RX J1856.4-3754 in PC mode for grade 0 events. We used a \( \text{CONST} \times \text{WABS} \times (\text{BBODYRAD} + \text{BBODYRAD}) \) model with the spectral parameters fixed to the values given in Beuermann et al. (2006).
3.3.2. The modelling of the shelf from photons above \(\sim 2\) keV

Before the release of the v009 RMFs, the spectral fits of heavily absorbed sources (with \(N_H\) typically larger than \(10^{22} \text{ cm}^{-2}\)) in either PC or WT mode showed an underestimation of the modelled redistributed counts at low energies corresponding to the shelf (see the red curves in Fig. 15). As discussed in Sect. 2.1.3, the physical origin of the shelf, and hence its modelling, is complex. To improve the CCD response model, we decided to rescale the shelf for incident photons above 2 keV, since this is a straightforward approach. The result of this rescaling significantly improves the residuals at low energy when fitting spectra of heavily absorbed sources in both modes (see the black curves in Fig. 15). While the rescaling of the PC shelf did not change the QE at high energy because the shelf is at least two orders of magnitude below the photo-peak, the rescaling of the shelf in WT mode increased the QE by \(\sim 10\%\) at 6 keV. This increase of the high-energy QE in WT mode also gives a better agreement with expectation of the grade ratios between the PC and WT modes (see Sect. 3.4). This new modelling was included in the release of v009 RMFs.

3.3.3. Origin of the low-energy shoulder from high-energy photons

For low-energy photons (below about 2 keV), the low-energy shoulder of the line profile can be modelled successfully by charge losses at the interface between silicon and oxide layer. However, the same process cannot completely explain the low-energy shoulder seen in the line profile of high-energy photons. Hence, the pre-launch PC and WT RMFs (v006) were not able fully to model the line profile for high-energy photons (see the bottom panel in Fig. 7).

Tests performed after launch showed that an artificial increase of the split threshold in the CCD response model results in an increase of sub-threshold losses, and hence a better modelling of the shoulder. This empirical technique was implemented in the v007 RMFs. Even if the global result was to improve significantly the residuals around the shoulder (see Fig. 6a in Osborne et al. 2005), this technique was not entirely satisfactory since residuals were still present and the physical origin was unidentified. The other drawback was that the QE curve in PC mode showed discontinuities (smaller than 5\%) due to the use of different values of the threshold depending on the energy range (see
Fig. 17. PC grade 0–12 spectrum of the $^{55}$Fe source on the XRT camera door fitted using the v009 RMF. The low energy shoulders of the lines are now correctly modelled using the Pavlov & Nousek formalism (compare to Fig. 7 lower panel).

Fig. 16), although these small discontinuities had no noticeable impact on the spectral fitting.

Pavlov & Nousek (1999) have stressed that when a photon interacts in the field-free region, the resulting charge cloud no longer has the profile of a 2D Gaussian, because it experiences free diffusion in this region before being distorted when penetrating the depletion region where the charge is collected. The authors gave an analytical formalism to describe the resulting shape of the charge cloud as a function of the depth of interaction. The resulting profile shows more extended wings which naturally favour the increase of sub-threshold losses for a given threshold value. The implementation of the Pavlov & Nousek formalism in our CCD response model gives good results as shown in Fig. 17. This new modelling was included in the release of v009 RMFs.

3.3.4. Feature around 0.9–1.0 keV in WT mode

Fits of high statistical quality WT spectra have revealed 10% systematic residuals around 0.9–1.0 keV, as shown in Fig. 18. An ad-hoc dip was added to the WT v008-v010 ARFs around 0.9 keV in order to suppress these residuals. However, this approach was not entirely satisfactory. These systematic residuals are due to a RMF redistribution issue. Indeed, as explained in Sect. 2.1.3, the surface charge losses are modelled by a loss function $f$ so that its parameters are different in different energy segments. 1 keV corresponds to a boundary between two energy segments for which there is a slight discontinuity in the description of the loss function. We modified the parameters of the loss function in the 1–2 keV range in order slightly to change the monochromatic line input profile, as shown in Fig. 19 for 1.2 keV photons. New WT grade 0 and 0–2 RMFs (i.e. v011) were computed using this new description. These v011 RMFs give very good performance as shown by the red residuals in Fig. 18 (also see Sect. 4.1).

3.4. Investigation of the QE shape from in-flight calibration

3.4.1. Overview of the QE calibration

The pre-launch QE was calibrated using measurements across the XRT energy range (0.3–10 keV) made at the Leicester calibration facility. However, some of these measurements were corrupted during the data taking process indicating that some of the low energy QE values were not valid.

It is not straightforward to obtain a direct measure of the QE in orbit, since the overall instrument spectral response depends on the mirror, filter transmission and CCD responses. Early fitting results suggested that the effective area needed to be rescaled between modes and grade selection due to QE uncertainties. It was also necessary to introduce corrections around the silicon and oxygen edges to obtain flat residuals when fitting spectra in both PC and WT mode. As discussed in Sect. 3.2, the correction around the oxygen edge was eventually found to be needed due to energy offsets in both modes.

We discuss below possible explanations accounting for the changes implemented in the ARFs and how they can be transferred to the CCD response model.

3.4.2. The silicon Kα edge and the low-energy QE shape

Since the detector consists of silicon bulk, and the effective area has a maximum in the 1.5–2.2 keV energy band, it is essential to take special care when modelling the Si Kα edge (1.839 keV).
The new ARF v011 (red) which includes the correction of the CCD QE just above the Si Kα edge (see text in Sect. 3.4.2). The residuals seen in black above 2.2 keV are due to the improper modelling of the Au M-shell (2.0–3.5 keV) edges in the theoretical ARF. A correction in the Au edge region (2.2–4 keV) was introduced in the ARFs after launch in order to flatten the residuals above 2.2 keV (red residuals).

Fits of several bright sources in both WT and PC modes using pre-launch RMFs demonstrated that the modelling of the silicon edge was not completely correct, as shown by the black residuals below 2 keV in Fig. 20 for WT mode. The residuals above 2.2 keV are due to an improper modelling of the Au M-shell edge region (2.0–3.5 keV) in the theoretical ARF. This ARF is made of the filter transmission response SWXTRANS20010101V005.FITS and the effective area (v004), which is computed by a ray-tracing code (Cusumano et al. 2005).

Initially, a correction was implemented in the v007-v010 PC and WT ARFs to flatten the residuals in the 1.8–2.2 keV energy range. However, that correction suffers from the effects of energy scale offsets which could not be entirely corrected at those times. Since then, we have been able to correct the XRT data from these effects (see Sect. 3.2). This enabled us to establish that the problem was related to an over-prediction of the QE in our CCD response just above the Si Kα edge (1.84–2.2 keV) rather than a redistribution issue. A straightforward solution to correct the QE above the Si edge was to implement a correction based on the XMM-MOS QE curve, which shows a deeper profile at these energies. Unlike the Swift-XRT, the XMM/MOS QE from the XMM-SAS 7.1.2 was calibrated with a synchrotron beam in Saclay, allowing for accurate measurements around the Si edge. This correction, along with a correction of the Au edge region (2.2–4 keV) in the ARFs produced after launch, gives good results in WT mode (see the red curve in Fig. 20). A similar correction was implemented in the new v011 PC ARFs.

Keay et al. (1995) stressed that the QE shape just above the Si edge was strongly dependent on the electrodes structure and composition of their JET-X CCD. They showed that the silicon contributes 65% of the QE shape above the edge, while the oxide and nitride of silicon contribute at 28% and 7%, respectively. As shown in Fig. 3, the description of the electrode structure in the CCD pixel geometry used to generate the XRT RMFs is relatively simple. In reality, there is an overlap of three different electrodes. An explanation for the QE over-prediction just above the silicon edge could be that the thicknesses of the different materials in the CCD geometry need to be more accurately specified. However, variation in thickness of the Si and SiO2 layers in the electrode and finger structures did not allow us to converge towards adequate thickness values for these layers to fully model the QE just above the silicon edge.

Nevertheless, from in-flight calibration we noticed that the total effective area at low energy needs to be decreased in both WT and PC modes to obtain correct flux levels and spectral parameters. Again, the electrode thicknesses appeared to be underspecified, since more low-energy photons will be stopped in the finger and electrode structures.

Another possible explanation accounting for the QE reduction at low-energy is that the etching of the electrode and finger structure did not result in the designed electrode widths, and some residual material was left as shown in Fig. 3. The residual material acts as an extra absorption layer for low-energy photons and so reduces the QE at low energy. As a test we reduced the open electrode area by slightly increasing the channel stop width (by 1 μm) and the finger as shown in Fig. 21 (top panel), corresponding to an open area reduction of 10.6%. The bottom panel in Fig. 21 shows a comparison of the WT grade 0–2 QE curve when using the new geometries (in red and green) and that from the WT grade 0–2 RMF v010 (in black). A less than 10% decrease of the QE is obtained at the energy of the oxygen edge (0.543 keV). This is consistent with the ad-hoc reduction implemented in the WT v007-v010 ARFs.

New WT ARFs (v011) were created by rescaling the theoretical ARF below 2 keV using the green QE curve in the lower panel in Fig. 21 and by introducing the CCD QE correction just above the silicon edge.
above the Si Kα edge as discussed above, while the Au M-shell region was corrected using celestial continuum sources. These new WT grade 0 and 0–2 ARFs have similar shapes except in the 1.5–1.84 keV energy range where the WT grade 0–2 ARF is rescaled down by less than 2% with respect to the WT grade 0 ARF in order to flatten residuals below 2% (see Fig. 3 in Godet et al. 2008). Figures 20 (red curve) and 23 show WT spectra of Mkn 421 fitted using an absorbed bending power-law and the new v011 response files. This plot shows the very good performance of the v011 WT RMFs/ARFs, since the residuals across the 0.3–10 keV energy range are better than 3% and the systematic errors are less than 2% (also see Sect. 4.1).

3.4.3. Discrepancy in the effective area between PC and WT modes

We expect that differences in the effective area between PC and WT modes would be due to the differences in the event grading in these two modes. However, it was necessary to scale down the effective area in PC mode (for both grade 0 and 0–12) by a factor larger than expected from the simple differences in the event grading, in order to reproduce the correct flux levels for the same calibration targets (see the top panel in Fig. 22; see Sect. 3.2 in Godet et al. 2008). Indeed, while the shape of the PC grade 0–12 effective area is similar to that of the WT grade 0–2 effective area above the Si Kα edge (as expected from the event grading), the WT grade 0 effective area is larger than the PC grade 0–12 effective area below ~1.84 keV remains unclear.

There is also a difference in the effective area at low energy (below 0.5 keV) between the PC grade 0 and WT grade 0 effective areas. The fact that the WT grade 0 events contain the PC grade 0, 1 & 3 events may account for the discrepancy. However, the lower panel in Fig. 22 shows that there are some differences in the Cas A spectra between WT grade 0 and PC grades 0+1+3 in the 1–3 keV band. To extract these spectra, we used 2005 data collected prior to the apparition of the bad columns, and the data were processed using the same central (80 DN) and split (80 DN) event thresholds. Below ~1 keV, the differences observed between the two spectra may be partially due to differences in the kernel redistribution between the modes (see Fig. 6). That suggests that the observed differences in effective area at low energy cannot be due to simple differences in the event grading.

4. In flight spectroscopic performance and caveats

We discuss in this section the in-flight spectroscopic performance of the v011 response files when fitting data collected at a substrate voltage of \( V = 0 \) V. For all the fits shown below, the PSF and exposure map corrections were taken into account in the ARFs using the version 5.5 of the task xrtmkarf of the xrtdas software package (Capalbi et al. 2005). We compare the fitting results with those found using other in-orbit X-ray instruments. We also discuss current caveats in the XRT spectral response: i) the line broadening due to the build-up of charge traps on the CCD over time and methods to handle it; ii) the impact of the permanent increase of the substrate voltage from 0 V to 6 V on the performance of the v011 response files.
Table 4. Summary of the spectral parameters obtained when fitting Swift-XRT, XMM-Newton, Chandra and RXTE data for several continuum sources.

<table>
<thead>
<tr>
<th>Mode</th>
<th>Grade</th>
<th>Source</th>
<th>Model</th>
<th>$N_H$ (×10^{22} cm^{-2})</th>
<th>$\Gamma$ or/and $kT$ (keV)</th>
<th>$F_{\text{obs}}$ [0.3–10 keV] (×10^{-11} erg cm^{-2} s^{-1})</th>
<th>PN</th>
<th>XMM-Newton results</th>
<th>MOS1</th>
<th>MOS2</th>
<th>RXTE results</th>
</tr>
</thead>
<tbody>
<tr>
<td>PC</td>
<td>0–12</td>
<td>PKS 2155-304</td>
<td>WABS*POW 0.0124</td>
<td>2.538 ± 0.025</td>
<td>(4.12–15.16)</td>
<td>2.676 ± 0.007</td>
<td>2.590 ± 0.010</td>
<td>2.560 ± 0.010</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>PC</td>
<td>0</td>
<td>PKS 0745-19</td>
<td>TBABS*MEKAL</td>
<td>2.523 ± 0.028</td>
<td>(4.86–15.39)</td>
<td>6.55 ± 0.19</td>
<td>0.74 ± 0.06</td>
<td>(4.44–4.53)</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>PC</td>
<td>0–12</td>
<td>SNR G21.5</td>
<td>TBABS*POW 0.54</td>
<td>6.60 ± 0.22</td>
<td>(4.76–4.86)</td>
<td>3.06 ± 0.05</td>
<td>3.25 ± 0.08</td>
<td>3.23 ± 0.08</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>PC</td>
<td>0</td>
<td>SNR G21.5</td>
<td>TBABS*POW 0.35</td>
<td>6.54 ± 0.25</td>
<td>(5.05–5.18)</td>
<td>1.76 ± 0.021</td>
<td>1.792 ± 0.036</td>
<td>1.839 ± 0.037</td>
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<td></td>
<td></td>
</tr>
<tr>
<td>PC</td>
<td>0–12</td>
<td>RX J1856.4-3754</td>
<td>WABS*POW 0.003</td>
<td>3.5 ± 0.12</td>
<td>(4.75–4.86)</td>
<td>4.08 ± 0.031</td>
<td>4.45 ± 0.05</td>
<td>4.59 ± 0.06†</td>
<td></td>
<td></td>
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</tr>
<tr>
<td>PC</td>
<td>0</td>
<td>RX J1856.4-3754</td>
<td>WABS*POW 0.0018</td>
<td>1.834 ± 0.086</td>
<td>4.72 ± 0.154</td>
<td>0.944 ± 0.005</td>
<td>0.950 ± 0.010</td>
<td>1.009 ± 0.010</td>
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</tbody>
</table>

Table 5. The second part of Table 4.

<table>
<thead>
<tr>
<th>Mode</th>
<th>Grade</th>
<th>Source</th>
<th>Model</th>
<th>$N_H$ (×10^{22} cm^{-2})</th>
<th>$\Gamma$ or/and $kT$ (keV)</th>
<th>$F_{\text{obs}}$ [0.3–10 keV] (×10^{-11} erg cm^{-2} s^{-1})</th>
<th>PN</th>
<th>XMM-Newton results</th>
<th>MOS1</th>
<th>MOS2</th>
<th>RXTE results</th>
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<tbody>
<tr>
<td>WT</td>
<td>0–2</td>
<td>3C 273</td>
<td>WABS*POW 0.0179</td>
<td>1.57 ± 0.04</td>
<td>(0.67–15.16)</td>
<td>1.646 ± 0.011</td>
<td>1.500 ± 0.028</td>
<td>1.533 ± 0.025</td>
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</tr>
<tr>
<td>WT</td>
<td>0</td>
<td>3C 273</td>
<td>WABS*POW 0.0179</td>
<td>0.50 ± 0.030</td>
<td>(0.74–15.04)</td>
<td>0.74 ± 0.03</td>
<td>0.89 ± 0.004</td>
<td>0.72 ± 0.004</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>WT</td>
<td>0</td>
<td>3C 273</td>
<td>WABS*POW 0.0179</td>
<td>0.136 ± 0.060</td>
<td>(0.80–15.11)</td>
<td>0.186 ± 0.011</td>
<td>0.304 ± 0.015</td>
<td>0.266 ± 0.014</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>WT</td>
<td>0</td>
<td>3C 273</td>
<td>WABS*POW 0.0179</td>
<td>16.1 ± 0.3</td>
<td>(0.95–15.10)</td>
<td>16.1 ± 0.3</td>
<td>15.3 ± 0.1</td>
<td>15.3 ± 0.14</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>WT</td>
<td>0</td>
<td>3C 273</td>
<td>WABS*POW 0.0179</td>
<td>10.2 ± 0.2†</td>
<td>(1.05–15.12)</td>
<td>8.5 ± 0.1†</td>
<td>9.5 ± 0.1†</td>
<td>9.3 ± 0.1†</td>
<td></td>
<td></td>
<td></td>
</tr>
</tbody>
</table>

* The abundance parameter was left as a free parameter.
** The spectra were extracted using a 40 arcsec radius circle for both Swift-XRT and XMM-Newton data. Extended source ARFs were specially created to fit the XRT spectra.
† The values of the observed flux are given in the 2–10 keV energy range.
‡ The model is CONST*TBABS(BODYRAD+BBODYRAD) (see Beuermann et al. 2006). All the parameters are fixed ($N_H = 1.1 \times 10^{22}$ cm$^{-2}$, $kT_1 = 62.8$ eV and $kT_2 = 32.3$ eV) except the constant factor.
§ The lowest temperature black-body component has a minor impact in the XRT energy range. It was introduced by Beuermann et al. (2006) to fit the EUVE data as well as the Chandra data.
†† Values of the constant factor for the model described in Beuermann et al. (2006).
Fig. 23. Plots showing the best fits to different celestial sources when using the v011 PC and WT response files. a) WT grade 0 (black) and grade 0−2 (red) spectra of the blazar Mkn 421 observed in June 2006. The spectral model is an absorbed bending power-law (i.e. \( W A B S \times \text{exp}[\alpha + \beta \ln(E)] \)) with the column density fixed at \( N_H = 1.6 \times 10^{20} \) cm\(^{-2}\) (Kalberla et al. 2005). Each spectrum contains over \( 1.6 \times 10^6 \) counts. The spectra were heavily rebinned to better emphasize the statistical residuals obtained for such high statistical quality data. The residuals are better than 3% over the XRT energy range. b) Simultaneous XMM-Newton, Swift and RXTE observations of 3C 273 performed in July 2005 showing the PN (black), MOS1 (red), MOS2 (green), RXTE (blue) and XRT WT grade 0−2 (cyan) fit using a \( \text{WABS}\times\text{POWERLAW} + \text{2BBODY} \) model. c) Simultaneous Swift-XRT and Swift-BAT observation of Sco X-1 performed in April 2008 showing the XRT WT grade 0−2 (black) and BAT (red) fit. The data were fitted using a \( \text{CONST}\times\text{WABS} (\text{BODYRAD} + \text{COMPTT}) \) model with \( \text{CONST} \) fixed to 1 for the XRT data and left free when fitting the BAT data (\( \text{CONST} = 0.93 \pm 0.04 \), the errors being given at 2.71σ). The XRT/WT spectrum was extracted using an annulus region with an inner radius of 25 pixels since the data were heavily piled-up due to the high count rate of the source (2020 counts s\(^{-1}\) when using a full circle extraction region). d) Fits of PSR 0540-69 (the pulsar and the nebula): (blue) Swift-XRT PC grade 0−12; (green) XMM-PN pattern 0−4; (red) XMM-MOS2 pattern 0−12; (black) XMM-MOS1 pattern 0−12. The model is a \( \text{WABS}\times\text{VNEI}\times\text{POWERLAW} \) model. e) Fits of the cluster PKS 0745-19: (red) Swift-XRT PC grade 0−12; (black) XMM-MOS1 pattern 0−12. The model is a \( \text{WABS}\times\text{MEKAL} \) model with the abundances left free.

The spectral analysis of joint BAT-XRT GRB spectra during overlapping time intervals showed relatively good agreement between the two instruments, within 10% in most cases. Figure 23 need to be rescaled in the future. The WT grade 0 and grade 0−2 fluxes derived from the fits of our WT calibration sources agree with each other within the error bars (see Table 4).
observed in June 2006 data. The top panel in Fig. 25 gives an example of a charge trap formed just after launch in the column experiencing a charge loss. The top panel in Fig. 25 illustrates how powerful this technique can be in restoring the spectral resolution of the XRT; the Cas A Si line FWHM measured from corrected LETX 78. The operation of the CCD at relatively high temperatures (from $-70 \degree C$ to $-50 \degree C$) may partially fill the shallowest traps since the level of the thermally induced dark current is higher than that expected at the designed operating temperature of $-100 \degree C$ (see Sect. 4.3).

Trap-induced line broadening is difficult to model since it may depend on the energy of the incident photons and the source intensity. Another uncertainty comes from the fact that the location and depth of the charge traps are unknown. Because all XRT spectral response files released so far have an incomplete modelling of the effect of CTI or traps, we urge caution in the interpretation of apparently sharp spectral features observed in XRT data from March 2007 onwards using the current calibration files.

Prospects to deal with the line broadening are under investigation:

Characterization of traps with the largest depth: we are experimenting with a technique based on the characterization of the location and energy offset induced by charge traps with the largest depth. The bottom panel in Fig. 25 illustrates how powerful this technique can be in restoring the spectral resolution of the XRT; the Cas A Si line FWHM measured from corrected
RMF monochromatic line photo-peak of the v011 WT RMFs, once convolved by \( f \), is multiplied by a factor \( B \) which tracks the CTI increase over time.

To test this technique, we first calibrated the function \( f \) using March 2007 data, and we computed experimental WT RMFs with a broadened kernel. As illustrated in Fig. 26 (the top left panel), which shows the best fits of the March 2007 WT spectra of Mkn 421 (with an average count rate of 45 count s\(^{-1}\)) using these RMFs along with the v011 WT ARFs, the residuals around the instrumental edges are flattened when compared to Fig. 24 (bottom panel). We also investigated whether variation of the CCD temperature could have a significant impact on the trap properties, and so the line broadening. To do so, we considered four temperature ranges with a width of 5 \(^\circ\)C from –70 \(^\circ\)C to –52 \(^\circ\)C using Mkn 421 data from March 2007 up to August 2007. We did not notice any significant change in the residuals around the instrumental edges when fitting the WT spectra using the experimental WT RMFs, even though the monitoring of the on-board corner sources has revealed a trend with temperature (a ~25% increase in the \( FWHM \) at 5.9 keV from –70 \(^\circ\)C to –50 \(^\circ\)C).

We also tested these experimental WT RMFs on data from June 2007 up to September 2007 for other celestial sources with lower count rates, such as the SNR B0102-723 (1 count s\(^{-1}\)) and the soft neutron star RX J1856.4-3754 (0.3 count s\(^{-1}\)), to check the RMF kernel broadening and for any temporal evolution of the line broadening. Indeed, the higher the source count rate, the more likely the charge traps are to be filled; thus, it could be expected that brighter sources show a less significant broadening. However, since the XRT operates at much higher temperatures than it was designed for, most of the small charge traps should be already filled. Figure 26 shows the very good performance of these experimental WT RMFs. Specifically we see no intensity effect for sources between 0.3 count s\(^{-1}\) to 70 count s\(^{-1}\). Moreover, their use enables us to retrieve in the case of RX J1856.4-3754 (June 2007 data) a normalisation consistent with that found using 2005–2006 PC and WT data (see Sect. 3.3.1). This is because the new WT RMFs show a slight decrease of the QE at low energy to take into account the fraction of events lost below the on-board event threshold due to the effect of charge traps (see Fig. 27).

### 4.3. Increase of the substrate voltage to 6V

As discussed in Sect. 3.2.3, the XRT operates at higher than expected temperatures, resulting in significant thermally-induced noise appearing as low energy events. From experiments performed at the Leicester calibration facility on the *Swift* flight spare CCD-22 devices, we have demonstrated that raising the substrate voltage to \( V_s = 6 \text{ V} \) reduces the dark current, since the volume of silicon in which carriers are generated is reduced (Osborne et al. 2005; Godet et al. 2007b). Figure 28 clearly illustrates the benefit of raising the substrate voltage, since, for the same level of dark current, it is now possible to operate the CCD at a 3–4 \(^\circ\)C warmer temperature, and hence to collect useful science data up to ~50 \(^\circ\)C, before excessive hot pixels compromise the data. The only minor drawback of raising this voltage is that it induces a decrease of the depletion depth, and therefore of the QE at high energy and just below the Si edge (~1.5–1.84 keV), due to the lower transparency of the silicon in this energy range (see Fig. 4). The increase of the substrate voltage also results in a change in the gain \( C_0 \), since the gain of the output FET is also modified in this new configuration.
Fig. 26. WT spectra of celestial sources using the v011 WT ARFs and/or the experimental broadened WT RMFs: (Top left panel) Fits of the Mkn 421 data from March 2007 using the experimental broadened WT RMFs. The WT grade 0 (black) and 0−2 (red) spectra contain more than $2 \times 10^5$ counts and were fitted using the same model as given in Fig. 24 (bottom panel). (Top right panel) SNR 2E 0102-723 from June 2007 data (black: v011 WT grade 0−2 RMF; red: new broadened WT grade 0−2 RMF). The WT grade 0−2 spectrum contains more than $2.2 \times 10^4$ counts. The spectral model is based on an XMM/RGS-PN model (see Plucinsky et al. 2008). The spectrum was extracted using data when the source was not located on the bad columns. We did not apply any PSF correction since the source is extended, and there is no tool in the ground software to generate extended ARFs. (Bottom panel) RX J1856.4-3754 from June 2007. The spectra contain more than $2.9 \times 10^3$ counts. The spectral model is the same as given in Sect. 3.3.1. The value of the constant factor is $C = 0.90 \pm 0.02$ for grade 0 (black) and $C = 0.94 \pm 0.03$ for grades 0−2 (red). All the data were processed with the new WT gain file SWXWTGAINS010101v008.FITS (see Sect. 3.2.4).

Fig. 27. WT grade 0−2 QE curves in the 0.2−1 keV energy band: (black) RMF v010, (red) RMF v011 and (green) broadened WT RMF v011. The loss of QE at low energy in the broadened WT RMF mimics the loss of events below the on-board central energy threshold due to the effect of charge traps.

Numerical simulations performed using our CCD response model and laboratory measurements made on a spare detector have shown that the QE decrease should be small (less than 10% at 6 keV; Osborne et al. 2005; Godet et al. 2007b). Short observations of two bright celestial targets with $V_{ss}$ set to 6 V – Cas A (2.2 ks in PC mode and 0.8 ks in WT mode) and the Crab (0.6 ks in WT mode) – were also performed to estimate the on-board effective area change and to create new PC and WT gain files. The QE changes were measured to be $\sim$7% at 6 keV and less than 10% in the 1.5−1.84 keV range. These $V_{ss} = 6$ V gain files were released as version 007 prior to the permanent change (see Table 2). The change in substrate voltage has made it necessary...
changes allow us to describe the CCD response well. We showed that the v011 XRT response files, calibrated using data collected at $V_{ss} = 0$ V, give good performance on continuum and line sources in both PC and WT mode when compared to other X-ray instruments in the 0.3–10 keV energy band (the recommended bandpass) with a systematic error of less than 3% in both modes over 0.3–10 keV and better than 10% in absolute flux.

We also showed that the XRT spectral response calibration was complicated by various effects, such as energy offsets, related to the way the CCD is operated in orbit. We described how these effects can be corrected in the ground processing software thanks to the task XRTWTCORR in WT mode and the task XRTPCBIAS in PC mode, and the release of temperature-dependent gain files. We stressed that the CCD started showing evidence of degradation of its spectroscopic performance (line broadening, small residuals around the instrumental edges and change in the low-energy response) when fitting spectra of celestial sources from the middle of 2007. This is due to the build-up of charge traps in the CCD, produced by high-energy proton and radiation damage. We are developing RMFs with a broadened kernel, enabling us to handle the line broadening over time. The preliminary results in WT mode are promising. Before the release of broadened kernel RMFs in either mode, we recommend that users should be cautious in any interpretation of the data.

In order to improve further the XRT spectral performance, the substrate voltage was raised permanently to $V_{ss} = 6$ V on-board on 2007 August 30. This change resulted in a slight decrease of the QE at high energy ($E > 3$ keV) and just below the Si edge (1.0–1.8 keV). This QE change is really only noticeable when fitting high statistical quality spectra with more than $10^5$ counts. An intense phase of re-calibration of the instrument is on-going to update the spectral response files. In the meantime, we recommend the use of the v011 response files, and we advice the user to be cautious in the spectral analysis of XRT data until the response files are updated.

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5. Conclusion
We described in detail our Monte-Carlo simulation, computing the Swift-XRT PC and WT RMFs. The response model is mainly based on a physical description of the interaction of photons in the CCD. We showed how we used in-flight calibration to improve the XRT spectral response (the low-energy response, the line profile and the shelf) by implementing empirical corrections when it was not possible to implement physical ones. All the
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